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Address	FSME Frontier Semiconductor Europe 196, rue du Rocher de Lorzier Bât C Centr'Alp 38430 MOIRANS
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Country	France
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PRODUCTS OR MACHINERY

Frontier Semiconductor, Inc, (FSM), offers a range of advanced metrology products and solutions for semiconductor and MEMS applications, including measurement systems for film stress, wafer bow, local stress & strain in Si, SiGe and SOI using Raman Spectroscopy characterization techniques for new films, such as Thermal Desorption Spectroscopy, Quantitative Adhesion Testers, Ultra-thin Wafer Substrate.

Optical Metrology
Electrical Metrology
Material Characterization

Company Profile of **FSME Frontier Semiconductor Europe**

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